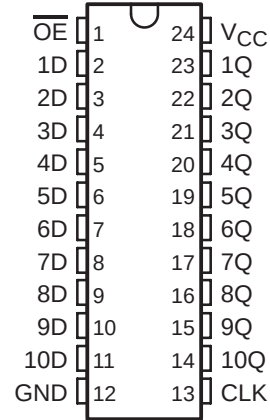


SN54ALS29821, SN74ALS29821 10-BIT BUS-INTERFACE FLIP-FLOPS WITH 3-STATE OUTPUTS

SDAS145B – JANUARY 1986 – REVISED JANUARY 1995

- Functionally Equivalent to AMD's AM29821
- Provide Extra Data Width Necessary for Wider Address/Data Paths or Buses With Parity
- Outputs Have Undershoot-Protection Circuitry
- Power-Up High-Impedance State
- Buffered Control Inputs Reduce dc Loading Effects
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (NT) and Ceramic (JT) 300-mil DIPs

SN54ALS29821 . . . JT PACKAGE
SN74ALS29821 . . . DW OR NT PACKAGE
(TOP VIEW)



description

These 10-bit edge-triggered D-type flip-flops feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. These devices are particularly suitable for implementing wider buffer registers, I/O ports, bidirectional bus drivers with parity, and working registers.

On the positive transition of the clock (CLK) input, the Q outputs are true to the data (D) input.

A buffered output-enable ($\overline{OE}$) input can place the ten outputs in either a normal logic state (high or low logic levels) or a high-impedance state. The outputs also are in the high-impedance state during power-up and power-down conditions. The outputs remain in the high-impedance state while the device is powered down. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

$\overline{OE}$ does not affect the internal operation of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54ALS29821 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74ALS29821 is characterized for operation from 0°C to 70°C .

FUNCTION TABLE
(each flip-flop)

INPUTS			OUTPUT Q
$\overline{OE}$	CLK	D	
L	$\uparrow$	H	H
L	$\uparrow$	L	L
L	L	X	Q_0
H	X	X	Z

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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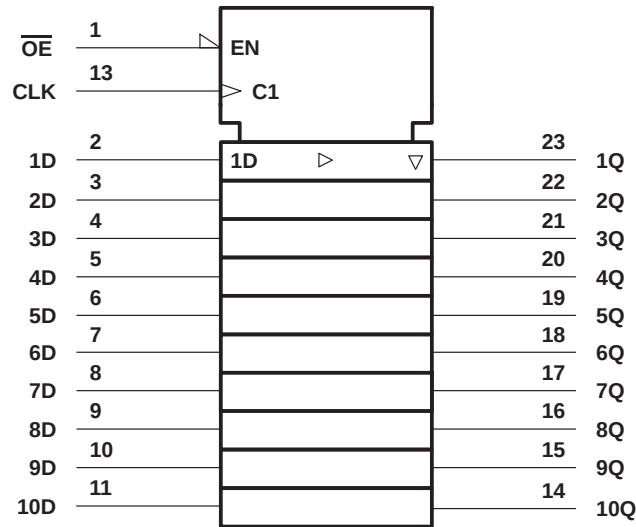
SN54ALS29821, SN74ALS29821

10-BIT BUS-INTERFACE FLIP-FLOPS

WITH 3-STATE OUTPUTS

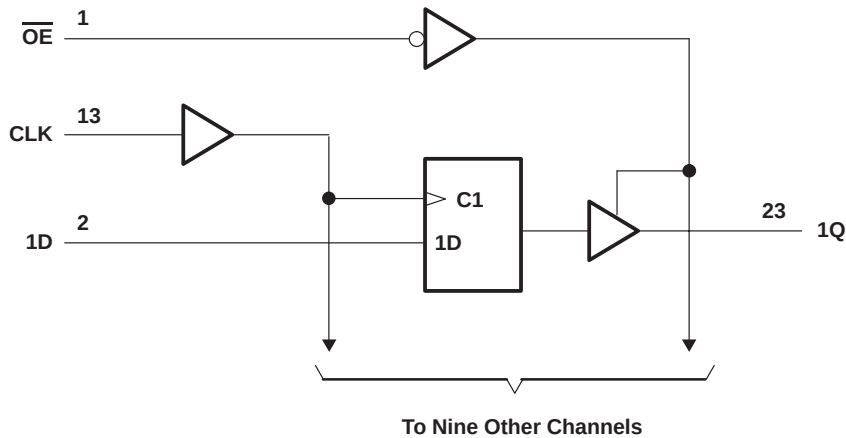
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logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V_{CC}	7 V
Input voltage, V_I	5.5 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T_A : SN54ALS29821	-55°C to 125°C
SN74ALS29821	0°C to 70°C
Storage temperature range	-65°C to 150°C

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

SN54ALS29821, SN74ALS29821 10-BIT BUS-INTERFACE FLIP-FLOPS WITH 3-STATE OUTPUTS

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recommended operating conditions

		SN54ALS29821			SN74ALS29821			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V _{IH}	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
I _{OH}	High-level output current			–24			–24	mA
I _{OL}	Low-level output current			48			48	mA
t _w	Pulse duration, CLK high or low	7			7			ns
t _{su}	Setup time, data before CLK↑	4			4			ns
t _h	Hold time, data after CLK↑	2			2			ns
T _A	Operating free-air temperature	–55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS29821			SN74ALS29821			UNIT
			MIN	TYP†	MAX	MIN	TYP†	MAX	
V _{IK}	V _{CC} = 4.75 V, I _I = –18 mA				–1.2			–1.2	V
V _{OH}	V _{CC} = 4.75 V	I _{OH} = –15 mA	2.4	3.3		2.4	3.3		V
		I _{OH} = –24 mA	2	3.1		2	3.1		
V _{OL}	V _{CC} = 4.75 V, I _{OL} = 48 mA			0.35	0.5		0.35	0.5	V
I _{OZH}	V _{CC} = 5.25 V, V _O = 2.4 V				50			20	μA
I _{OZL}	V _{CC} = 5.25 V, V _O = 0.4 V				–50			–20	μA
I _I	V _{CC} = 5.25 V, V _I = 5.5 V				0.1			0.1	mA
I _{IH}	V _{CC} = 5.25 V, V _I = 2.7 V				20			20	μA
I _{IL}	V _{CC} = 5.25 V, V _I = 0.4 V				–0.5			–0.2	mA
I _{OS} ‡	V _{CC} = 5.25 V, V _O = 0		–75		–250	–75		–250	mA
I _{CC}	V _{CC} = 5.25 V, Outputs open			80	115		80	115	mA

† All typical values are at V_{CC} = 5 V, T_A = 25°C.

‡ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.



SN54ALS29821, SN74ALS29821

10-BIT BUS-INTERFACE FLIP-FLOPS

WITH 3-STATE OUTPUTS

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switching characteristics (see Figure 1)

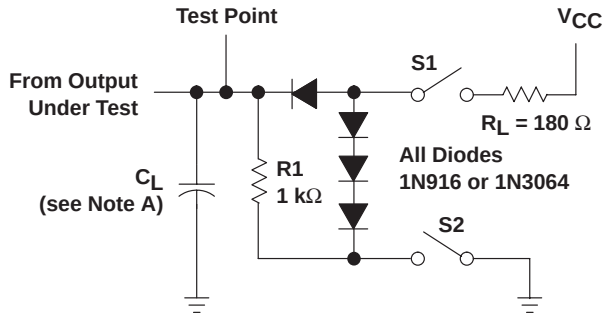
PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	V _{CC} = MIN to MAX [†] , T _A = MIN to MAX [†]				UNIT
				SN54ALS29821		SN74ALS29821		
				MIN	MAX	MIN	MAX	
t _{PLH}	CLK	Any Q	C _L = 50 pF	2	11.5	2	10	ns
t _{PHL}				2	11.5	2	10	
t _{PLH}	CLK	Any Q	C _L = 300 pF	2	21	16		ns
t _{PHL}				2	21	16		
t _{PZH}	$\overline{\text{OE}}$	Any Q	C _L = 50 pF	1	17	14		ns
t _{PZL}				1	17	14		
t _{PZH}	$\overline{\text{OE}}$	Any Q	C _L = 300 pF	1	25	20		ns
t _{PZL}				1	29.5	23		
t _{PHZ}	$\overline{\text{OE}}$	Any Q	C _L = 50 pF	1	16	14		ns
t _{PLZ}				1	14	12		
t _{PHZ}	$\overline{\text{OE}}$	Any Q	C _L = 5 pF	1	12	9		ns
t _{PLZ}				1	11	9		

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

SN54ALS29821, SN74ALS29821 10-BIT BUS-INTERFACE FLIP-FLOPS WITH 3-STATE OUTPUTS

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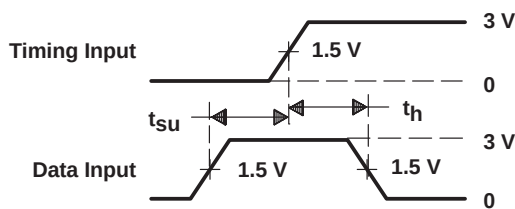
PARAMETER MEASUREMENT INFORMATION



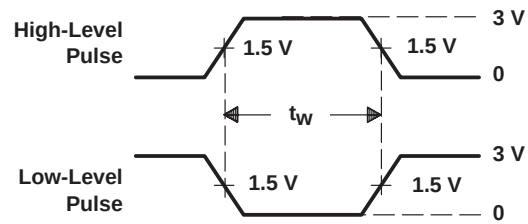
LOAD CIRCUIT

SWITCH POSITION TABLE

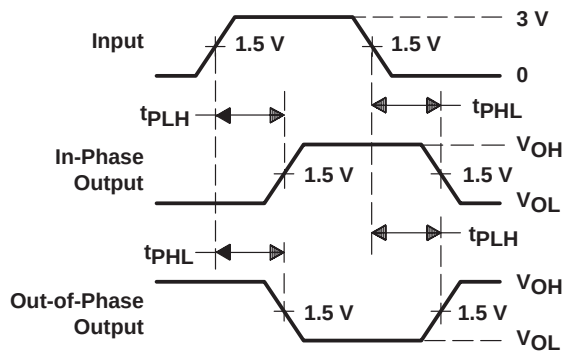
TEST	S1	S2
t_{PLH}	Closed	Closed
t_{PHL}	Closed	Closed
t_{PZH}	Open	Closed
t_{PZL}	Closed	Open
t_{PHZ}	Closed	Closed
t_{PLZ}	Closed	Closed



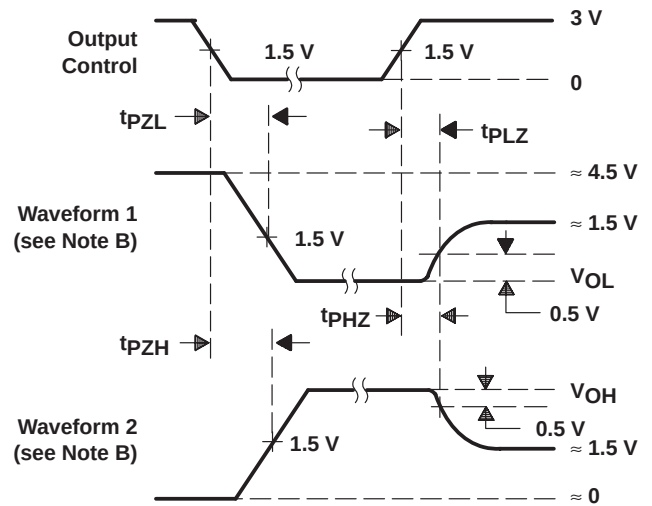
VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS
PULSE DURATIONS



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS

- NOTES: A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 10$ MHz, $Z_O = 50 \Omega$, $t_r \leq 2.5$ ns, $t_f \leq 2.5$ ns.

Figure 1. Load Circuit and Voltage Waveforms



PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
5962-9061601LA	Active	Production	CDIP (JT) 24	15 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9061601LA SNJ54ALS29821J T
SN74ALS29821DW	Active	Production	SOIC (DW) 24	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS29821
SN74ALS29821DW.A	Active	Production	SOIC (DW) 24	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS29821
SNJ54ALS29821JT	Active	Production	CDIP (JT) 24	15 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9061601LA SNJ54ALS29821J T
SNJ54ALS29821JT.A	Active	Production	CDIP (JT) 24	15 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9061601LA SNJ54ALS29821J T

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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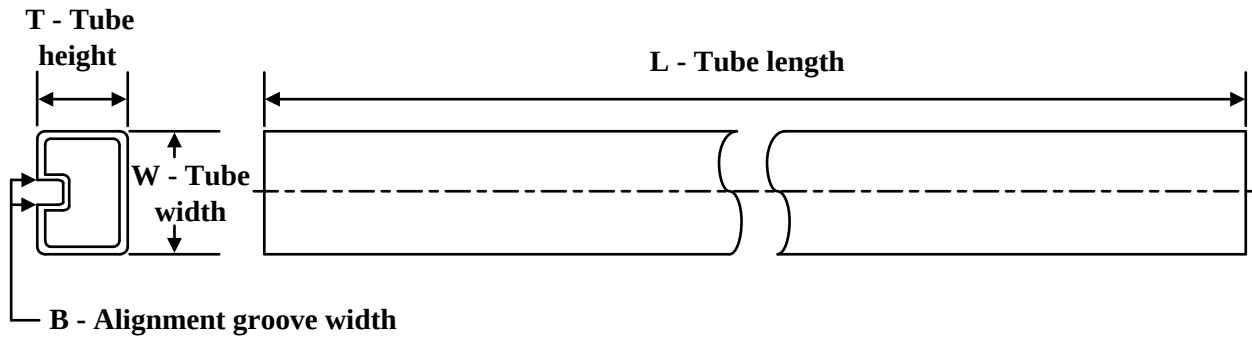
OTHER QUALIFIED VERSIONS OF SN54ALS29821, SN74ALS29821 :

- Catalog : [SN74ALS29821](#)
- Military : [SN54ALS29821](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

TUBE

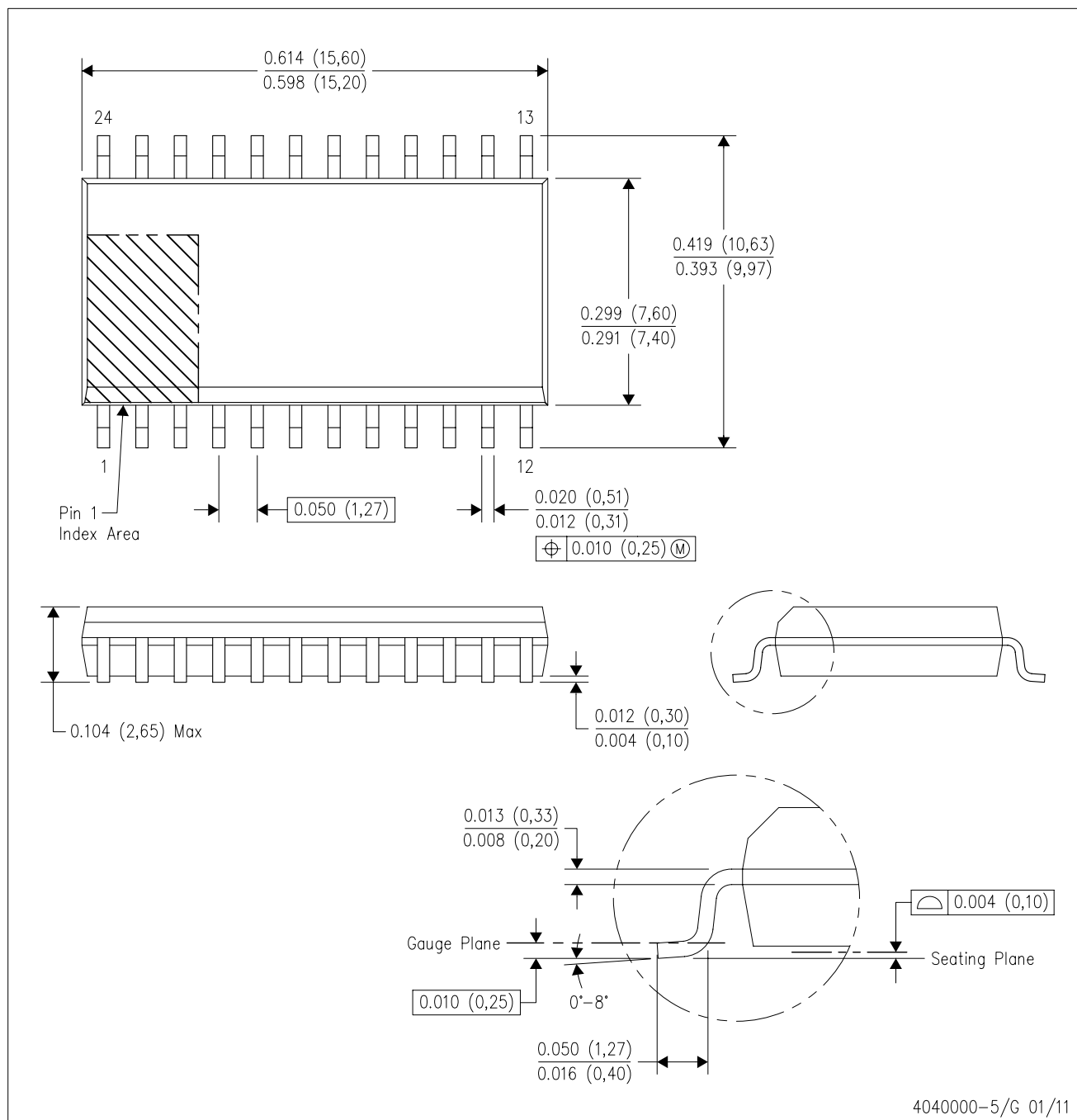


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
SN74ALS29821DW	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74ALS29821DW.A	DW	SOIC	24	25	506.98	12.7	4826	6.6

DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE

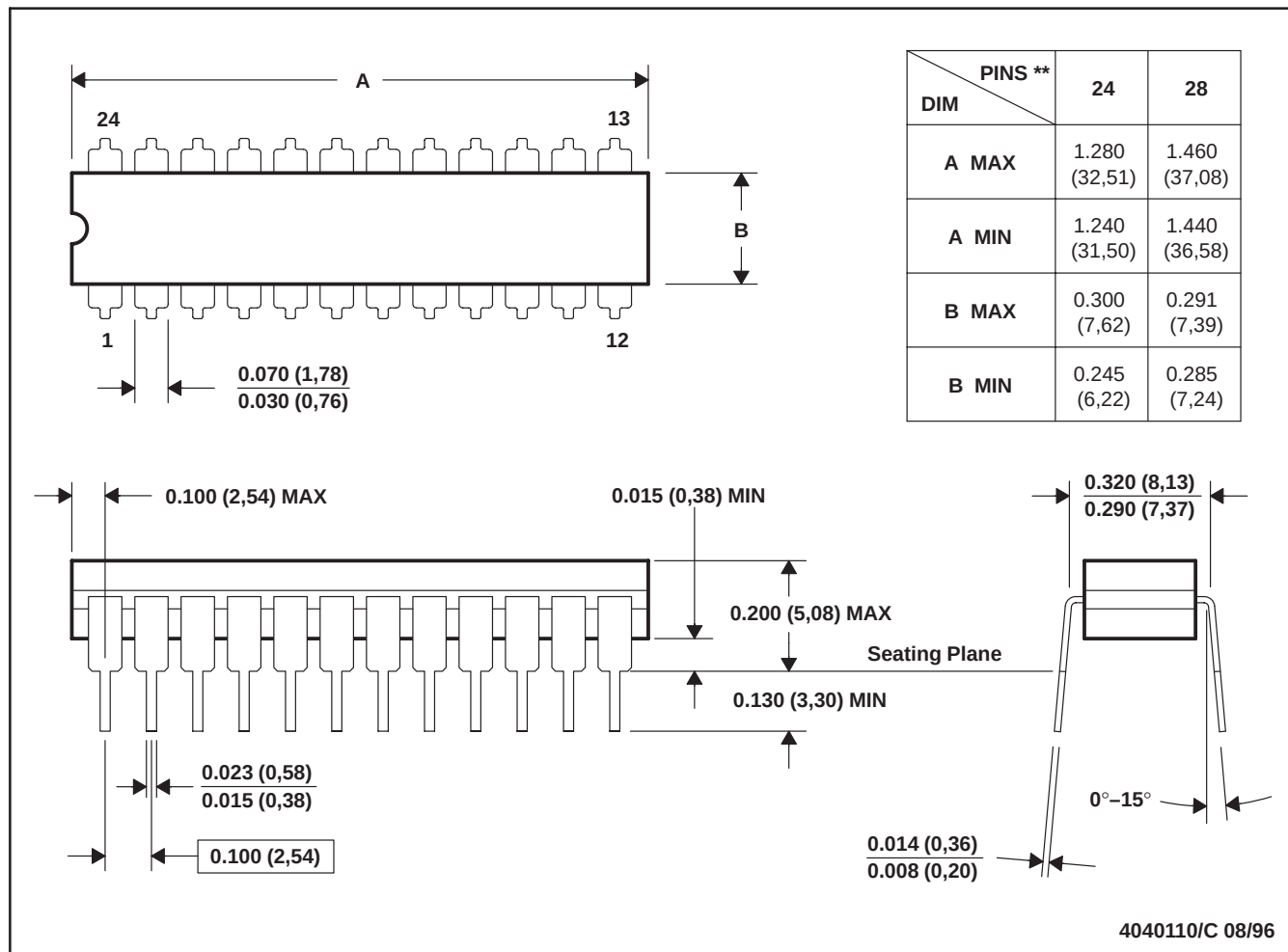


- NOTES:
- All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.
 - This drawing is subject to change without notice.
 - Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 - Falls within JEDEC MS-013 variation AD.

JT (R-GDIP-T**)

CERAMIC DUAL-IN-LINE

24 LEADS SHOWN



- NOTES:
- All linear dimensions are in inches (millimeters).
 - This drawing is subject to change without notice.
 - This package can be hermetically sealed with a ceramic lid using glass frit.
 - Index point is provided on cap for terminal identification.
 - Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB

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